SN5433, SN54LS33, SN7433, SN74LS33 QUADRUPLE 2-INPUT POSITIVE NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS

SDLS101

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

description

These devices contain four independent 2-input NOR buffer gates with open-collector outputs. Open-collector outputs require resistive pull-up to perform logically but can deliver higher V_{OH} levels and are commonly used in wired-AND applications.

The SN5433 and SN54LS33 are characterized for operation over the full military temperature range of -55 °C to 125 °C. The SN7433, and SN74LS33 are characterized for operation from 0 °C to 70 °C.

FUNCTION TABLE (each gate)

INP	UTS	OUTPUT
A	в	Y
н	х	L
х	н	L
L	Ĺ	Н

logic symbol[†]

b



[†]This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

DECEMBER 1983-REVISED MARCH 1988

SN5433, SN54LS33J OR W PACKAGE SN7433N PACKAGE SN74LS33D OR N PACKAGE (TOP VIEW)								
1Y [] 1A []2 1B []3		E ''						
2Y []4	11	🗅 4A						
2 A [] [©]	10	🛛 ЗҮ						
2B 🗍 6	9	🛛 зв						
GND 🗍 🤊	8	<u>П</u> ЗА						

SN54LS33 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic diagram



positive logic

$$Y = \overline{A + B}$$
 or $Y = \overline{A \cdot B}$

PRODUCTION DATA documents centain information current as of publication date. Products conform to specifications par the terms of Texas instruments standard warrenty. Production processing does not necessarily include testing of all parameters.



SN5433, SN54LS33, SN7433, SN74LS33 QUADRUPLE 2-INPUT POSITIVE-NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS

schematics (each gate)



 $\begin{array}{c} \textbf{LS33}\\ \textbf{INPUTS}\\ \textbf{A} \\ \textbf{I}7 \text{ k}\Omega \\ \textbf{$

Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC} (see Note 1)
Input voltage: '33
′LS33
Off-state output voltage \ldots 7 V
Operating free-air temperature: SN54'
SN74'
Storage temperature range \ldots —65°C to 150°C
IOTE 1: Voltage values are with respect to network ground terminal.



SN5433, SN7433 QUADRUPLE 2-INPUT POSITIVE NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS

recommended operating conditions SN5433 SN7433 UNIT NOM MAX MIN NOM MAX MIN Vcc 5 5.5 4.75 5 5.25 v 4.5 Supply voltage ۷ 2 2 Vн High-level input voltage VIL 0.8 0.8 ٧ Low-level input voltage ∨он High-level output voltage 5.5 5.5 v 48 10L Low-level output current 48 mΑ 0 70 ٩Ç Operating free-air temperature - 55 125 TΑ

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		SN5433	\$N7433	
	TEST CONDITIONS.	MIN TYP [‡] MAX	ΜΙΝ ΤΥΡ [‡] ΜΑΧ	
VIK	$V_{CC} = MIN, I_I = -12 \text{ mA}$	- 1.5	- 1.5	V
юн	$V_{CC} = MIN, V_{IL} = 0.8 V, V_{OH} = 5.5 V$		0.25	
	$V_{CC} = MIN, V_{IL} \approx 0.7 V, V_{OH} = 5.5 V$	0.25		mA
VOL	$V_{CC} = MIN, V_{IH} = 2 V, I_{OL} = 16 mA$	0.2 0.4	0.2 0.4	v
 ų	$V_{CC} = MAX, V_{ } = 5.5 V$	1	1	mΑ
ин	$V_{CC} = MAX, V_1 = 2.4 V$	40	40	μA
μ_	$V_{CC} = MAX, V_1 = 0.4 V$	- 1.6	- 1.6	mA
ССН	$V_{CC} = MAX, V_I = 0$	3 6	3 6	mA
ICCL	V _{CC} = MAX, See Note 2	9 16.5	9 16.5	mA

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. [‡]All typical values are at V_{CC} = 5 V, T_A = 25 °C. NOTE 2: One input at 4.5 V, all others at 0 V.

switching characteristics, $V_{CC} = 5 V$, $T_A = 25 °C$ (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	түр	MAX	UNIT
tPLH			B: - 122 kg C: - 50 pE		10	15	ពន
^t PHL	A or B		$R_{L} = 133 k\Omega, C_{L} = 50 pF$		12	18	ns
^t PLH		1	D 10010 C 1505		15	22	ns
^t PHL			$R_{L} = 133 k\Omega, C_{L} = 150 pF$		16	24	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

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SN54LS33, SN74LS33 QUADRUPLE 2 INPUT POSITIVE NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS

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recommended operating conditions

14							
SN54LS33			SN74LS33				
MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
4.5	5	5.5	4.75	5	5.25	V	
2			2			V	
		0.7			0.8	V	
		5.5	_		5.5	V	
		12			24	mΑ	
- 55		125	0		70	°C	
	MIN 4.5 2	MIN NOM 4.5 5 2	SN54L\$33 MIN NOM MAX 4.5 5 5.5 2 0.7 5.5 12 12 12	SN54L\$33 S MIN NOM MAX MIN 4.5 5 5.5 4.75 2 2 2 2 0.7 5.5 12 12	SN54L\$33 SN74L\$ MIN NOM MAX MIN NOM 4.5 5 5.5 4.75 5 2 2 0.7 2 2 5.5 12 12 12 12 12	SN54LS33 SN74LS33 MIN NOM MAX MIN NOM MAX 4.5 5 5.5 4.75 5 5.25 2 2 2 2 0.7 0.8 5.5 5.5 5.5 5.5 5.5 5.5 12 12 24 24 24	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS †			S	SN54LS33		SN74LS33			
				MIN	TYP \$	MAX	MIN	TYP‡	MAX	UNIT
VIK	V _{CC} = MIN,	l _† ≃ – 18 mA				- 1.5	[- 1.5	V
юн	VCC = MIN,	VIH = 2 V,	VIL = MAX, VOH = 5.5 V	1		0.25			0.25	mA
Mari	$V_{CC} = MIN$	V _{IH} = 2 V,	$V_{IL} = MAX, I_{OL} \approx 12 mA$		0.25	0.4		0.25	0.4	4 V
VOL	V _{CC} = MIN,	VIL = MAX,	l _{OL} ≖ 24 mA	1				0.35	0.5	
4	VCC = MAX,	VI = 7 V				0.1			0.1	mA
ін	VCC = MAX,	VI = 2.7 V				20			20	μA
IL	V _{CC} = MAX,	V1 = 0.4 V				- 0,4			- 0.4	mΑ
Іссн	VCC = MAX,	VI = 0		1	1.8	3.6		1.8	3.6	mA
ICCL	V _{CC} = MAX,	See Note 2			6.9	13.8		6.9	13.8	mA

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. [‡]All typical values are at V_{CC} = 5 V, T_A = 25 °C. NOTE 2: One input at 4.5 V, all others at 0 V.

switching characteristics, VCC = 5 V, TA = 25° C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON	MIN	TYP	MAX	UNIT	
^t PLH	A or B	v	RL ~ 667 Ω,	C, = 45 pF		20	32	ns
tPHL	2010			CL = 45 pF		18	28	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

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